Quasi-Particle Propagation through Interfaces of Weakly and Strongly Correlated Systems

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1 Introduction

- Understanding strongly correlated systems is grand challenge of theoretical physics
- Strongly and weakly interacting particles usually described by different methods
- How to describe a heterostructure thereof while keeping spatial resolution?
- Hierarchy of correlations is a way to solve for the one-site, two-site etc. density operator [1]
- Here: discrete lattice model of solids that provides a mathematical description of systems with a well-defined amount of electronic correlations

2 Hierarchy of correlations [1]

- Systematic expansion in inverse powers of coordination number 1/Z
- Correlations from reduced density matrices $\hat{\rho}_{\mu\nu} = tr_{\mu\nu}(\hat{\rho})$, i.e., $\hat{\rho}_{\mu\nu} = \hat{\rho}_{\mu\nu}^{corr} + \hat{\rho}_{\mu}\hat{\rho}_{\nu}$
- Von-Neumann equation and split up of correlations $i\partial_t \hat{\rho}_{\mu\nu\lambda}^{\text{corr}} = F_3\left(\hat{\rho}_{\mu}, \hat{\rho}_{\mu\nu}^{\text{corr}}, \hat{\rho}_{\mu\nu\lambda}^{\text{corr}}, \hat{\rho}_{\mu\nu\lambda\kappa}^{\text{corr}}\right)$ $i\partial_t \hat{\rho}_{\mu} = F_1\left(\hat{\rho}_{\mu}, \hat{\rho}_{\mu\nu}^{\text{corr}}\right) \quad i\partial_t \hat{\rho}_{\mu\nu}^{\text{corr}} = F_2\left(\hat{\rho}_{\mu}, \hat{\rho}_{\mu\nu}^{\text{corr}}, \hat{\rho}_{\mu\nu\lambda}^{\text{corr}}\right)$

6 Double interface

- Mott insulator between two semiconducting leads
- Transmission given by

0.8

0.6

0.4

 $\frac{j^{\mathrm{trans}}}{j^{\mathrm{in}}}$

$$\frac{j_n^{\text{trans}}}{j_n^{\text{in}}} = \left| \frac{e^{id\kappa}e^{-i\kappa_{\text{semi}}d}(1-e^{i2\kappa})(1-e^{i2\kappa_{\text{semi}}})}{(1-e^{i\kappa}e^{i\kappa_{\text{semi}}})^2 - e^{i2d\kappa}(e^{i\kappa}-e^{i\kappa_{\text{semi}}})^2} \right|$$

Transmission probability through the
upper Hubbard band (dotted lines) over
the energy of the incoming wave
$$E/U$$

• Inside Mott bands

transmission channels

- Tunnelling inbetween
- Resonances $\kappa_{Mott} \cdot \pi = zd$



Open-Minded



CRC

Project B07

• Mean-field state $\hat{\rho}_{\mu}^{0}$ without correlations provides the hierarchy

 $\hat{\rho}_{\mu} = \mathcal{O}(Z^0), \quad \hat{\rho}_{\mu\nu}^{\text{corr}} = \mathcal{O}(1/Z), \quad \hat{\rho}_{\mu\nu\kappa}^{\text{corr}} = \mathcal{O}(1/Z^2), \quad \hat{\rho}_{\mu\nu\kappa\lambda}^{\text{corr}} = \mathcal{O}(1/Z^3)$ • Linearization around mean-field to first order yields dynamics of quasi-particles

 $i\partial_t \hat{\rho}^{\text{corr}}_{\mu\nu} = F_2\left(\hat{\rho}^0_\mu, \hat{\rho}^{\text{corr}}_{\mu\nu}\right)$

3 Fermi-Hubbard model & system

- Mott-insulator (strongly correlated) & semiconductor (weakly correlated)
- Fermi-Hubbard Hamiltonian: Hopping $\,T_{\mu
 u}$, Coulomb repulsion U_{μ} and on-site potential V_{μ} $\hat{H} = -\frac{1}{7} \sum T_{\mu\nu} \hat{c}^{\dagger}_{\mu\sigma} \hat{c}_{\nu\sigma} + \sum U_{\mu} \hat{n}_{\mu\uparrow} \hat{n}_{\mu\downarrow} + \sum V_{\mu} \hat{n}_{\mu\sigma}$
- U, V used to distinguish Mott and semiconductor
- Mott insulator at half-filling $\hat{\rho}^{0}_{\mu} = \left(|\uparrow\rangle_{\mu}\langle\uparrow|+|\downarrow\rangle_{\mu}\langle\downarrow|\right)/2$ $U^1_{\mu} = U, U^0_{\mu} = 0, V_{\mu} = 0$
- Effective particle $\hat{C}^1_{\mu\sigma}$ and hole $\hat{C}^0_{\mu\sigma}$ operators
- Assume hypercubic lattice $T_{\mu\nu} = T \delta_{\mu\nu\pm 1}$
- Factorization $\langle \hat{C}^{\dagger I}_{\mu s} \hat{C}^{J}_{\nu s} \rangle^{\text{corr}} = p^*_{\mu s I} p_{\nu s J}$
- Fourier transform parallel to interface
- Effective equations describing quasi-particle modes

semiconductor valence (conduction) band $\hat{\rho}^{0}_{\mu} = |\uparrow\downarrow\rangle_{\mu}\langle\uparrow\downarrow| \quad (|0\rangle_{\mu}\langle0|)$ $U^{i} = 0, V_{\mu} = V$



- Tunnelling probability approximated by
- $\frac{J_n^{\text{trains}}}{\dot{l}_n^{\text{in}}} \approx 4e^{-2d\kappa_{\text{Mott}}}(1 e^{-2\kappa_{\text{Mott}}})^2 (1 \cos(\kappa_{\text{semi}}))^2 \qquad e^{-\kappa_{\text{Mott}}} \approx \frac{4T(E U/2)}{7U^2}$

• Current vanishes in the middle of Mott gap E = U/2. Why?

- 7 Understanding vanishing tunnelling current
- Three-site toy model with second order process amplitude T^{\uparrow} and T^{\downarrow} [3] • Up spin \uparrow needs to pass either \uparrow or \downarrow

 $T^{\uparrow} = T^2/V$

 $T^{\downarrow} = -T^2/(U-V)$ $-(\uparrow\downarrow)-$

• Coherent sum of these two possibilites: $T^{\uparrow} + T^{\downarrow} = 0$ for V = U/2

$$\left(E - U_{\mu}^{I} - V_{\mu}\right)p_{\mu}^{I} + \langle \hat{n}_{\mu}^{I} \rangle^{0} \sum_{J} T_{\mathbf{k}}^{\parallel} p_{\mu}^{J} = -T \frac{\langle \hat{n}_{\mu}^{I} \rangle^{0}}{Z} \sum_{J} \left(p_{\mu-1}^{J} + p_{\mu+1}^{J}\right)$$

4 Mott insulator & semiconductor

• Plane wave ansatz $p_{\mu}^{I} = \alpha^{I} e^{i\kappa\mu} + \beta^{I} e^{-i\kappa\mu}$ in regions of constant U, V<u>Semiconductor</u> <u>Mott</u> $7 \quad \begin{bmatrix} F(II - F) \end{bmatrix}$

$$\cos \kappa_{\text{Mott}} = \frac{2}{2T} \left[\frac{E(U - E)}{E - U/2} - T_{\mathbf{k}}^{\parallel} \right]$$
$$E = \frac{1}{2} \left(U - T_{\mathbf{k}} \pm \sqrt{U^2 + T_{\mathbf{k}}^2} \right)$$

 $E = V - T_{\mathbf{k}}$

 $|\kappa| \propto \ln(V)$

$$\cos \kappa_{\rm semi} = \frac{Z}{2T} \left[V - E - T_{\rm k}^{\parallel} \right]$$

$$E = \frac{1}{2} \left(U - T_{\mathbf{k}} \pm \sqrt{U^2 + T_{\mathbf{k}}^2} \right)$$

- $|\kappa|$ finite for $U \to \infty$ • $\kappa \to \infty$ for E = U/2
- Divergence in the middle of the Mott gap suggest strong suppression of tunnelling

- The mean-field background $\hat{
 ho}^0_\mu$ of the Mott is a sum over N rows $P_N = \frac{N+1}{4N} \left(|T^{\uparrow}|^2 + |T^{\downarrow}|^2 \right) + \frac{N-1}{2N} \operatorname{Re}(T^{\uparrow}T^{\downarrow^*})$
- Probability falls as $P_N(V = U/2) \propto 1/N$ and $P_{N \gg 1} = |T^{\uparrow} + T^{\downarrow}|^2/4$
- Destructive interference of particle and hole channel in the middle of the Mott gap
 - P_N give the analytical formula with
 - 10^{-} perturbation theory amplitudes • W_N show numerically obtained transmission probabilty using the full Hamiltonian
 - $T_{\text{num}}^{\uparrow/\downarrow}$ uses amplitudes from the Zeno limit by analytical solution of the von-Neumann equations of the creation/ annihilation operators with the full Hamiltonian



Destructive interference of particle and hole current [2]

8 Conclusions & Outlook

- Hierarchy of correlations facilitates iterative scheme to solve von-Neumann equation
- 5 Single interface Reflection and Transmission

• Incoming wave from Mott $\begin{pmatrix} p_{\mu}^{0} \\ p_{\mu}^{1} \end{pmatrix} = \frac{1}{\sqrt{E^{2} + (E-U)^{2}}} \begin{pmatrix} E \\ E-U \end{pmatrix} \left[e^{i\kappa_{\text{Mott}}\mu} + Re^{-i\kappa_{\text{Mott}}\mu} \right]$

• $E \approx 0$ hole contributions dominate, $E \approx U$ particle contributions dominate

 $R = -\frac{1 - \exp\{-i(\kappa_{\text{Mott}} - \kappa_{\text{semi}})\}}{1 - \exp\{i(\kappa_{\text{Mott}} + \kappa_{\text{semi}})\}}$ $T = \mathcal{N}(2E - U)(1 + R)$

• Analogous to impedance mismatch: R = 0 for $\kappa_{Mott} = \kappa_{semi}$



Transmission probability for different semiconductor potentials V over the energy of the incoming wave E/U

 Semiconductor band edge needs to fall inside the Mott bands (dashed lines)

- Linearization around mean-field background gives effective dynamics of quasi-particles
- Single Mott-semiconductor interface reflection like electrodynamics impedance mismatch
- Transmission through Mott layer through bands and tunnelling current inbetween
- Destructive interference of particle and hole channel results in vanishing current at
- E = U/2 in the middle of the Mott band gap

Outlook

- → Include higher order correlations
- → Do different structures to build, e.g., energy filters
- Different mean-field backgrounds give different dispersion relations and hence different

[1] F. Queisser et al. Physical Review A 89.3, 033616 (2014) [2] J. Verlage et al. arXiv:2303.13507

[3] J. Splettstoesser et.al. Physical Review B86, 035432 (2012)